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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
09/729,058	12/04/2000	Anke Krasemann	GR 99 P 5363	6468	
75	90 03/29/2002				
LERNER AN	D GREENBERG, P.A.	EXAMINER			
POST OFFICE BOX 2480 HOLLYWOOD, FL 33022-2480			LUU, PHO M		
			ART UNIT	PAPER NUMBER	
•		2824			
			DATE MAILED: 03/29/2002		

Please find below and/or attached an Office communication concerning this application or proceeding.



# Office Action Summary

Application No. **09/729,058** 

Applicant(s)

Krasemann et al.

Examiner

Pho Luu

Art Unit 2824



	The MAILING DATE of this communication appears	on the cove	er sheet with	the correspondence address	
A SHO THE N - Exten aft - If the be - If NO co - Failur - Any r	ORTENED STATUTORY PERIOD FOR REPLY IS SET MAILING DATE OF THIS COMMUNICATION. sions of time may be available under the provisions of 37 Cter SIX (6) MONTHS from the mailing date of this communic period for reply specified above is less than thirty (30) days considered timely. period for reply is specified above, the maximum statutory mmunication. The to reply within the set or extended period for reply will, by received by the Office later than three months after the reply patent term adjustment. See 37 CFR 1.704(b).	FR 1.136 (a) cation. s, a reply wit period will a	. In no eventhin the statutoply and will use the applic	, however, may a reply be timely filed bry minimum of thirty (30) days will expire SIX (6) MONTHS from the mailing date of this ation to become ABANDONED (35 U.S.C. § 133).	
Status					
1) 🗆	Responsive to communication(s) filed on			·	
2a) 🗌	This action is <b>FINAL</b> . 2b) 💢 This ac	tion is non-	final.		
3) 🗆	Since this application is in condition for allowance closed in accordance with the practice under Ex pa	except for arte Quayle	formal mat , 1935 C.D	ers, prosecution as to the merits is . 11; 453 O.G. 213.	
Disposi	tion of Claims				
4) 💢	Claim(s) <u>1-20</u>			is/are pending in the application.	
4	a) Of the above, claim(s) <u>1-4</u>				
5) 🗆	Claim(s)			is/are allowed.	
6) 💢	Claim(s) <u>5-20</u>			is/are rejected.	
7) 🗆	Claim(s)				
8) 💢	Claims				
Applica	ition Papers				
• • —	The specification is objected to by the Examiner.			•	
10)	The drawing(s) filed on is/arc	e objected	to by the E	caminer.	
11)🔀	The proposed drawing correction filed on				
12)	The oath or declaration is objected to by the Exam				
13)反 a) ∫	under 35 U.S.C. § 119  Acknowledgement is made of a claim for foreign p  All b)□ Some* c)□ None of:  1. □ Certified copies of the priority documents ha  2. □ Certified copies of the priority documents ha  3. □ Copies of the certified copies of the priority of application from the International Burn	ve been re ve been re documents eau (PCT F	ceived. ceived in A <sub>l</sub> have been tule 17.2(a)	oplication No received in this National Stage	
*S	ee the attached detailed Office action for a list of t				
14) 🗆	Acknowledgement is made of a claim for domesti	c priority u	nder 35 U.S	5.C. § 119(e).	
Attachm	nent(s)				
15) 💢 N	lotice of References Cited (PTO-892)	18)	18] Interview Summary (PTO-413) Paper No(s).		
18) Notice of Draftsperson's Patent Drawing Review (PTO-948)		-	<ul> <li>19)  Notice of Informal Patent Application (PTO-152)</li> <li>20)  Other: Search History</li> </ul>		
17) 🔲 li	nformation Disclosure Statement(s) (PTO-1449) Paper No(s).	20) X Othe	r: Search Hi	story	

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#### **DETAILED ACTION**

## Response to Election/Restriction

1. Applicant's election without traverse of group II, claims 5-20 in Paper No. 7 filed February 19, 2002 is acknowledged.

### **Priority**

2. Receipt is acknowledged of papers submitted under 35 U.S.C. 119(a)-(d), which papers have been placed of record in the file.

# Inventorship

3. This application currently names joint inventors. In considering patentability of the claims under 35 U.S.C. 103(a), the examiner presumes that the subject matter of the various claims was commonly owned at the time any inventions covered therein were made absent any evidence to the contrary. Applicant is advised of the obligation under 37 CFR 1.56 to point out the inventor and invention dates of each claim that was not commonly owned at the time a later invention was made in order for the examiner to consider the applicability of 35 U.S.C. 103© and potential 35 U.S.C. 102(f) or (g) prior art under 35 U.S.C. 103(a).

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## Claim Rejections - 35 USC § 103

- 4. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
  - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 5. Claims 5-13, 17, and 19-20 are rejected under 35 U.S.C. 103(a) as being unpatentable over Iwai et al. (US. 4,327476).

Regarding claim 5. Iwai et al have discloses a capacitive electrode structure. The capacitive electrode (3) structure comprising the steps of a semiconductor substrate (1), a metal oxide layer (MOS) layer formed on said semiconductor substrate, an oxidation (Fig. 1) inhibiting or reduce layer on said metal oxide layer, and on said oxidation (12) inhibiting layer Iwai et al doesn't show the element of electrode apply in metal oxide layer, but does teach the formation of electrode isolation around the MOS capacitor be formed self aligned (column 2, lines 58-61).

It would have been obvious to one of ordinary skill in the art at the time the invention was made to form electrode on said oxidation corrosion while forming a capacitive electrode structure patterns since Iwai et al shows a capacitor electrode structure in a proper depth with a groove and is capable of increasing a capacity of a metal oxide semiconductor capacitor and reducing an area of the capacitor electrode structure.

Regarding claim 6. Iwai et al discloses that wherein said oxidation inhibiting layer is electrically conductive (column 2, lines 48-58).

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Regarding claim 7. Iwai et al discloses that wherein said electrode is formed by a metal layer on said electrically conductive oxidation inhibiting layer (column 2, lines 58-61).

Regarding claim 8. Iwai et al discloses that wherein said electrically conductive oxidation inhibiting layer is composed of tungsten nitride (column 3, lines 34-40).

Regarding claim 9. Iwai et al discloses that wherein said electrically conductive oxidation inhibiting layer is composed of titanium nitride (column 3, lines 34-40).

Regarding claim 10. Iwai et al discloses that wherein said oxidation inhibiting layer is not electrically conductive and said electrode is formed by a polysilicon layer on said oxidation inhibiting layer (column 4, lines 30-35).

Regarding claim 11. Iwai et al discloses that wherein said electrically non-conductive oxidation inhibiting layer is composed of a material having a high dielectric constant (column 1, lines 25-29).

Regarding claim 12. Iwai et al discloses that wherein said electrically non conductive oxidation inhibiting layer is composed of silicon nitride (column 3, lines 22-26).

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Regarding claim 13. Iwai et al discloses that wherein said metal oxide layer is composed of an oxygen rich material having a high dielectric constant (column 1, lines 25-29).

Regarding claim 17. Iwai et al discloses that which comprises a meta barrier layer between said metal oxide layer and said substrate (column 7, lines 14-17).

Regarding claim 19. Iwai et al discloses that wherein said metal barrier layer is composed of silicon nitride (column 3, lines 25-29).

Regarding claim 20. Iwai et al discloses that wherein said oxidation inhibiting layer comprises a nitrogen rich compound for preventing a diffusion of oxygen atoms through said oxidation inhibiting layer (column 7, lines 5-13).

6. Claims 14-16, and 18 are rejected under 35 U.S.C. 103(a) as being unpatentable over Iwai et al. (US. 4,327476) in view of Ackerman (US. 5,547706).

Regarding claim 14. The reference of Iwai et al shows all the limitations of the independent claim 5, and dependent claim 13 as noted above except for the metal oxide layer is composed of titanium dioxide as call in claim 14. However, it is well known in the art that the define of Ackerman teaches the metal oxide layer is composed of titanium dioxide (column 2, lines 42-46). Therefore, it would have been obvious to one having ordinary skill in the art at the time the invention was made to anodize the processes of metal oxide layer as taught by Ackerman

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in the anodization of Iwai et al in order to accomplishing up the process of capacitive electrode structure.

Regarding claim 15. Ackerman discloses that wherein said metal oxide layer is composed of tantalum pentoxide (column 1, lines 20-25).

Regarding claim 16. Ackerman discloses that wherein said metal oxide layer is composed of aluminum oxide (column 2, lines 42-46).

Regarding claim 18. Ackerman discloses that wherein said metal barrier layer is composed of silicon dioxide (column 1, lines 20-25).

#### Conclusion

7. Any inquiry concerning this communication or earlier communication from the examiner should be directed to Pho M. Luu whose telephone number is (703) 306-5943. The examiner can normally be reached on Monday through Friday from 9:00am to 5:30pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Richard Elms, can be reached on (703) 308-2816. My direct fax telephone number is 7003-746-4261. The official faxes for technology center 2800 should be sent to 703-872-9318. The official after final faxes for technology center 2800 should be send to 703-872-9319.

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Any inquiry of a general or relating to the status of this application or proceeding should be directed to the group receptionist whose telephone number is (703) 308-0956.

Pho M. Luu Art Unit 2824 March, 2002.

RICHARD ELMS

SUPERVISORY PATENT EXAMINER TECHNOLUGY CENTER 2850